


Search Notes 	Application/Control No. 10549407	Applicant(s)/Patent Under Reexamination ZHANG ET AL.
	Examiner SHIN-HON CHEN	Art Unit 2131

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - updated search)	4/10/08	S.C.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner